

Fischer Traceability Report SD 2012 02

Recertification of Au on Pd on Ni master standard foils

The Helmut Fischer GmbH applies master reference standards to quantify “standard calibration set” products. This report describes the recertification of the master reference standards for Au/Pd/Ni foils.

The mass per unit areas of the foils are traceable to reference materials with low uncertainties:

- Au values: traceable to Au/Pd/Ni/PCB Master reference materials (this means traceable to a combination of gravimetry /1/, FP-based XRF analysis /2/, and Rutherford backscattering /3/. Cf. Fischer Traceability Report VR 2011 01.
- Pd values: traceable to Au/Pd/Ni/PCB Master reference materials (this means a combination of gravimetry /1/, FP-based XRF analysis /2/, and Rutherford backscattering /3/) and self-supporting Pd foils quantified according to a gravimetric procedure accredited by either DKD or DAkkS /1/. Cf. Fischer Traceability Report SD 2012 01.
- Ni values traceable to self-supporting Ni foils (Sets 18761 and 15722) quantified according to a gravimetric procedure accredited by either DKD or DAkkS /1/.

Experimental

Fischerscope[®] X-RAY XDAL[®], 50 kV, 1 mm Al primary filter. aperture Ø 0.6 mm, DefMA Au/Pd/Ni/ (with background correction), Pd was measured, evaluation without Pd L radiation. The self-supporting foils were measured with a special “radiation trap” sample holder.

All samples were measured with 9 measurements with 120 s uniformly distributed over an area of 2 mm x 2 mm.

Since the measuring distance affects the geometry factor, it must be fixed within a small tolerance. The Fischerscope X-Ray system’s autofocus tool achieves an acceptable constant measuring distance of about $\pm 20 \mu\text{m}$.

The measurements were repeated several times to ensure consistency. For control purposes, various uncoated samples were checked.

Results of recalibration

All values converted from the mass per unit area data with the density for Au = $19,3 \text{ g/cm}^3$, Pd = 12 g/cm^3 and Ni = $8,9 \text{ g/cm}^3$. The given uncertainties are standard measuring uncertainties for a confidence level of 68,3 % ($k = 1$).

Discussion

As shown in the table above, in most cases the recertified values are very close to the old values. The differences are usually in the same order of magnitude as the measuring uncertainties. Although the reasons for these discrepancies cannot be explained in each case, the spatial inhomogeneity is probably an important issue which has not previously been accounted for. Consequently, the recalibrated results are mean values valid for the very restricted area of 2 mm x 2 mm.

Further basic reference material will be produced in future to achieve improved data with smaller measuring uncertainties.

References

- /1/ Reg. No. D-K-15076-01-00.
- /2/ V. Rößiger and B. Nensel, in "Handbook of practical X-Ray fluorescence analysis", Springer 2006, p. 554.
- /3/ S. Dill and V. Rößiger, Circuit world, 37 (2011), 2, 20.